



# BGA713L7

Single-Band UMTS LNA (700, 800 MHz)

## Data Sheet

Revision 3.0, 2010-10-04

RF & Protection Devices

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**BGA713L7 Single-Band UMTS LNA (700, 800 MHz)**

**Revision History: 2010-10-04, Revision 3.0**

**Previous Revision: 2010-05-26, Revision 2.0**

Page	Subjects (major changes since last revision)
all	Added UMTS bands XII, XVII and XX specification

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Last Trademarks Update 2010-06-09

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## 1 Features

Main features:

- Gain: 15.5 / -10 dB in high / low gain mode
- Noise figure: 1.1 dB in high gain mode
- Supply current: 4.8 / 0.5 mA in high / low gain mode
- Standby mode (< 2  $\mu$ A typ.)
- Output internally matched to 50  $\Omega$
- Inputs pre-matched to 50  $\Omega$
- 2 kV HBM ESD protection
- Low external component count
- Small leadless TSLP-7-1 package (2.0 x 1.3 x 0.39 mm)
- Pb-free (RoHS compliant) package



## Description

The BGA713L7 is a low current single-band low noise amplifier MMIC for UMTS bands XII, XIII, XIV, XVII and XX. The LNA is based upon Infineon's proprietary and cost-effective SiGe:C technology and comes in a low profile TSLP-7-1 leadless green package. This document specifies electrical parameters, pinout, application circuit and packaging of the chip.

Product Name	Package	Chip	Marking
BGA713L7	TSLP-7-1	T1533	B3

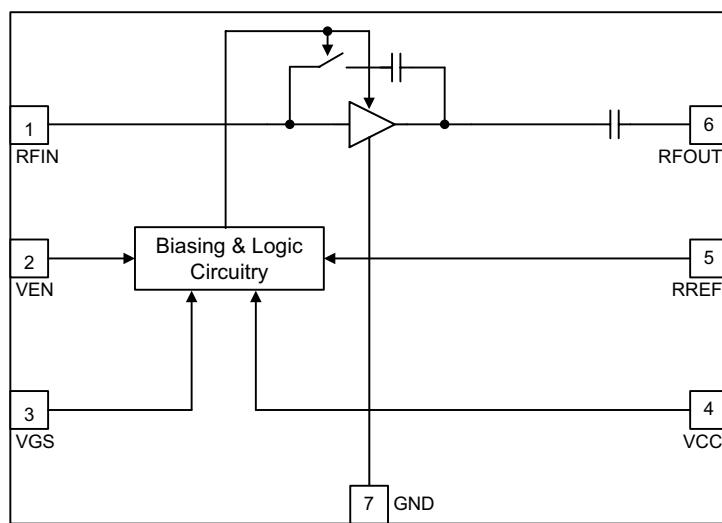


Figure 1 Block Diagram of Single-Band LNA

## 2 Electrical Characteristics

### 2.1 Absolute Maximum Ratings

**Table 1 Absolute Maximum Ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Supply voltage	$V_{CC}$	-0.3	–	3.6	V	–
Supply current	$I_{CC}$	–	–	10	mA	–
Pin voltage	$V_{PIN}$	-0.3	–	$V_{CC}+0.3$	V	All pins except RF input pins
Pin voltage RF input pins	$V_{RFIN}$	-0.3	–	0.9	V	–
RF input power	$P_{RFIN}$	–	–	4	dBm	–
Junction temperature	$T_j$	–	–	150	°C	–
Ambient temperature range	$T_A$	-30	–	85	°C	–
Storage temperature range	$T_{stg}$	-65	–	150	°C	–

**Attention:** Stresses above the max. values listed here may cause permanent damage to the device.  
**Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.**

### 2.2 Thermal Resistance

**Table 2 Thermal Resistance**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance junction to soldering point	$R_{thJS}$	–	150	–	K/W	–

### 2.3 ESD Integrity

**Table 3 ESD Integrity**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
ESD hardness HBM <sup>1)</sup>	$V_{ESD-HBM}$	–	2000	–	V	All pins

1) According to JESD22-A114

## 2.4 DC Characteristics

**Table 4 DC Characteristics,  $T_A = 25^\circ\text{C}$**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Supply voltage	$V_{CC}$	2.6	2.8	3.0	V	—
Supply current high gain mode	$I_{CCHG}$	—	4.8	—	mA	—
Supply current low gain mode	$I_{CCLG}$	—	0.50	—	mA	—
Supply current standby mode	$I_{CCOFF}$	—	0.1	—	$\mu\text{A}$	—
Logic level high	$V_{HI}$	1.5	2.8	—	V	All logic pins
Logic level low	$V_{LO}$	—	0.0	0.5	V	
Logic currents	$I_{HI}$	—	5.0	—	$\mu\text{A}$	All logic pins
	$I_{LO}$	—	0.1	—	$\mu\text{A}$	

## 2.5 Band Select / Gain Control Truth Table

**Table 5 Truth Table**

Control Voltage		State	
		Bands XII, XIII, XIV, XVII and XX	
VEN	VGS	HG	LG
H	L	OFF	ON
H	H	ON	OFF
L	L	STANDBY <sup>1)</sup>	
L	H		

1) In order to achieve minimum standby current it is encouraged to apply logic low-level at the VGS pin in standby mode although this is not mandatory.

## 2.6 Switching Time

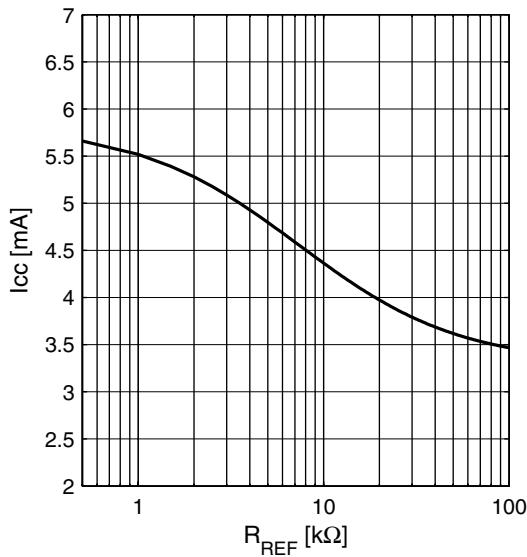
**Table 6 Typical switching times;  $T_A = -30 \dots 85^\circ\text{C}$**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Settling time gainstep	$t_{GS}$	—	1	—	$\mu\text{s}$	Switching LG $\leftrightarrow$ HG

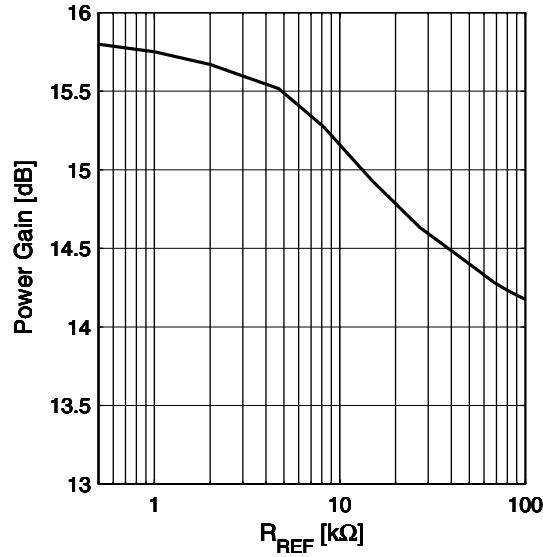
## 2.7 Supply Current and Power Gain Characteristics

Supply current high gain mode versus resistance of reference resistor  $R_{REF}$  see Figure 3 on Page 20; low gain mode supply current is independent of reference resistor).

**Supply Current**  $I_{CC} = f(R_{REF})$   
 $V_{CC} = 2.8 \text{ V}$



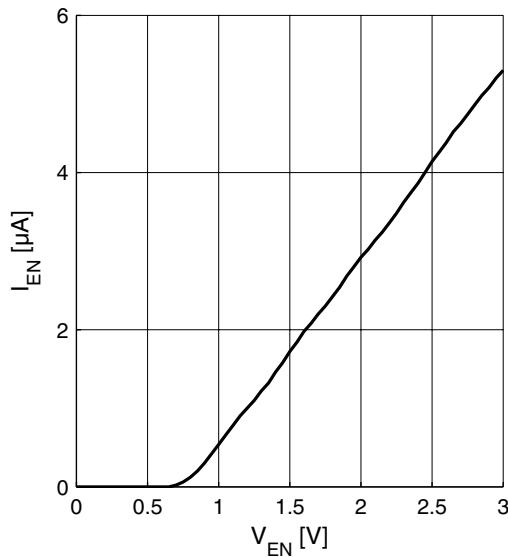
**Power Gain**  $|S_{21}| = f(R_{REF})$   
 $V_{CC} = 2.8 \text{ V}$



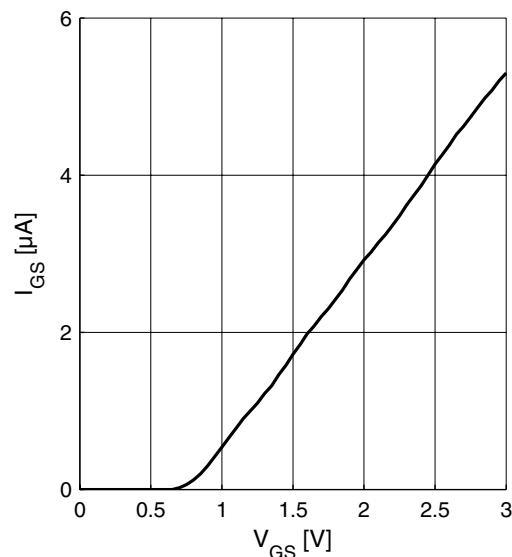
## 2.8 Logic Signal Characteristics

Current consumption of logic inputs VEN, VGS

**Logic currents**  $I_{EN} = f(V_{EN})$   
 $V_{CC} = 2.8 \text{ V}$



**Logic currents**  $I_{GS} = f(V_{GS})$   
 $V_{CC} = 2.8 \text{ V}$



## 2.9 Measured RF Characteristics UMTS Bands XII / XVII

**Table 7 Typical Characteristics 700 MHz Band,  $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 2.8 \text{ V}$ ,  $R_{REF} = 5.6 \text{ k}\Omega^1$**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Pass band range band XII		728		746	MHz	
Pass band range band XVII		734		746	MHz	
Current consumption	$I_{CCHG}$	–	4.8	–	mA	High gain mode
	$I_{CCLG}$	–	0.50	–	mA	Low gain mode
Gain	$S_{21HG}$	–	15.3	–	dB	High gain mode
	$S_{21LG}$	–	-9.9	–	dB	Low gain mode
Reverse isolation <sup>2)</sup>	$S_{12HG}$	–	-40	–	dB	High gain mode
	$S_{12LG}$	–	-9.9	–	dB	Low gain mode
Noise figure	$NF_{HG}$	–	1.1	–	dB	High gain mode
	$NF_{LG}$	–	9.9	–	dB	Low gain mode
Input return loss <sup>2)</sup>	$S_{11HG}$	–	-13	–	dB	50 $\Omega$ , high gain mode
	$S_{11LG}$	–	-14	–	dB	50 $\Omega$ , low gain mode
Output return loss <sup>2)</sup>	$S_{22HG}$	–	-27	–	dB	50 $\Omega$ , high gain mode
	$S_{22LG}$	–	-19	–	dB	50 $\Omega$ , low gain mode
Stability factor <sup>3)</sup>	$k$	–	>2.2	–		DC to 8 GHz; all gain modes
Input compression point <sup>2)</sup>	$IP_{1dBHG}$	–	-7	–	dBm	High gain mode
	$IP_{1dBBLG}$	–	-12	–	dBm	Low gain mode
$f_1 - f_2 = 1 \text{ MHz}$ $P_{f1} = P_{f2} = -37 \text{ dBm}$	$IIP3_{HG}$	–	-8	–	dBm	High gain mode
	$IIP3_{LG}$	–	-2	–	dBm	Low gain mode

1) Performance based on application circuit in Figure 2 on Page 19

2) Verification based on AQL; not 100% tested in production

3) Guaranteed by device design; not tested in production

## 2.10 Measured RF Characteristics UMTS Bands XIII / XIV

**Table 8 Typical Characteristics 700 MHz Band,  $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 2.8 \text{ V}$ ,  $R_{REF} = 5.6 \text{ k}\Omega^1$**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Pass band range band XIII		746		756	MHz	
Pass band range band XIV		758		768	MHz	
Current consumption	$I_{CCHG}$	–	4.8	–	mA	High gain mode
	$I_{CCLG}$	–	0.50	–	mA	Low gain mode
Gain	$S_{21HG}$	–	15.5	–	dB	High gain mode
	$S_{21LG}$	–	-9.8	–	dB	Low gain mode
Reverse isolation <sup>2)</sup>	$S_{12HG}$	–	-39	–	dB	High gain mode
	$S_{12LG}$	–	-9.8	–	dB	Low gain mode
Noise figure	$NF_{HG}$	–	1.1	–	dB	High gain mode
	$NF_{LG}$	–	9.8	–	dB	Low gain mode
Input return loss <sup>2)</sup>	$S_{11HG}$	–	-15	–	dB	50 $\Omega$ , high gain mode
	$S_{11LG}$	–	-12	–	dB	50 $\Omega$ , low gain mode
Output return loss <sup>2)</sup>	$S_{22HG}$	–	-15	–	dB	50 $\Omega$ , high gain mode
	$S_{22LG}$	–	-20	–	dB	50 $\Omega$ , low gain mode
Stability factor <sup>3)</sup>	$k$	–	>2.3	–		DC to 8 GHz; all gain modes
Input compression point <sup>2)</sup>	$IP_{1dBHG}$	–	-7	–	dBm	High gain mode
	$IP_{1dBBLG}$	–	-11	–	dBm	Low gain mode
$f_1 - f_2 = 1 \text{ MHz}$ $P_{f1} = P_{f2} = -37 \text{ dBm}$	$IIP3_{HG}$	–	-7	–	dBm	High gain mode
	$IIP3_{LG}$	–	-2	–	dBm	Low gain mode

1) Performance based on application circuit in Figure 3 on Page 20

2) Verification based on AQL; not 100% tested in production

3) Guaranteed by device design; not tested in production

## 2.11 Measured RF Characteristics UMTS Band XX

**Table 9 Typical Characteristics 800 MHz Band,  $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 2.8 \text{ V}$ ,  $R_{REF} = 5.6 \text{ k}\Omega^1$**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Pass band range		791		821	MHz	
Current consumption	$I_{CCHG}$	–	4.8	–	mA	High gain mode
	$I_{CCLG}$	–	0.50	–	mA	Low gain mode
Gain	$S_{21HG}$	–	15.9	–	dB	High gain mode
	$S_{21LG}$	–	-8.4	–	dB	Low gain mode
Reverse isolation <sup>2)</sup>	$S_{12HG}$	–	-38	–	dB	High gain mode
	$S_{12LG}$	–	-8.4	–	dB	Low gain mode
Noise figure	$NF_{HG}$	–	1.0	–	dB	High gain mode
	$NF_{LG}$	–	8.4	–	dB	Low gain mode
Input return loss <sup>2)</sup>	$S_{11HG}$	–	-16	–	dB	50 $\Omega$ , high gain mode
	$S_{11LG}$	–	-11	–	dB	50 $\Omega$ , low gain mode
Output return loss <sup>2)</sup>	$S_{22HG}$	–	-13	–	dB	50 $\Omega$ , high gain mode
	$S_{22LG}$	–	-27	–	dB	50 $\Omega$ , low gain mode
Stability factor <sup>3)</sup>	$k$	–	>2.3	–		DC to 8 GHz; all gain modes
Input compression point <sup>2)</sup>	$IP_{1dBHG}$	–	-6	–	dBm	High gain mode
	$IP_{1dBBLG}$	–	-10	–	dBm	Low gain mode
Inband IIP3 <sup>2)</sup> $f_1 - f_2 = 1 \text{ MHz}$ $P_{f1} = P_{f2} = -37 \text{ dBm}$	$IIP3_{HG}$ $IIP3_{LG}$	–	-8 -1	–	dBm	High gain mode Low gain mode

1) Performance based on application circuit in Figure 4 on Page 21

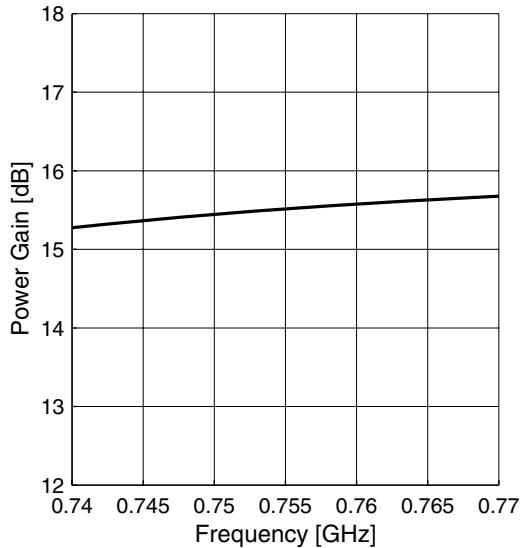
2) Verification based on AQL; not 100% tested in production

3) Guaranteed by device design; not tested in production

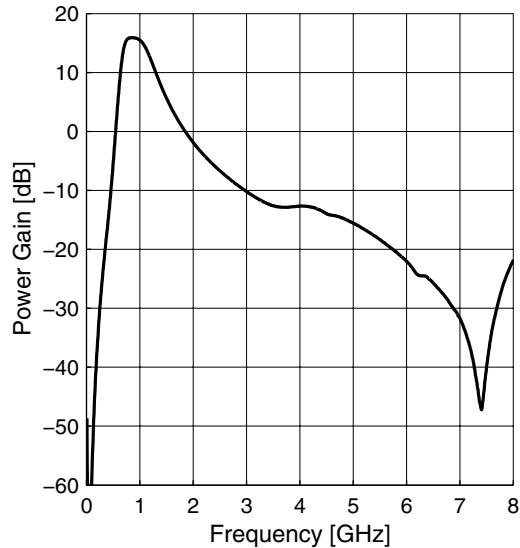
## 2.12 Measured Performance Band XIII High Gain Mode vs. Frequency

$T_A = 25^\circ\text{C}$ ,  $V_{CC} = 2.8 \text{ V}$ ,  $V_{GS} = 2.8 \text{ V}$ ,  $V_{EN} = 2.8 \text{ V}$ ,  $R_{REF} = 5.6 \text{ k}\Omega$

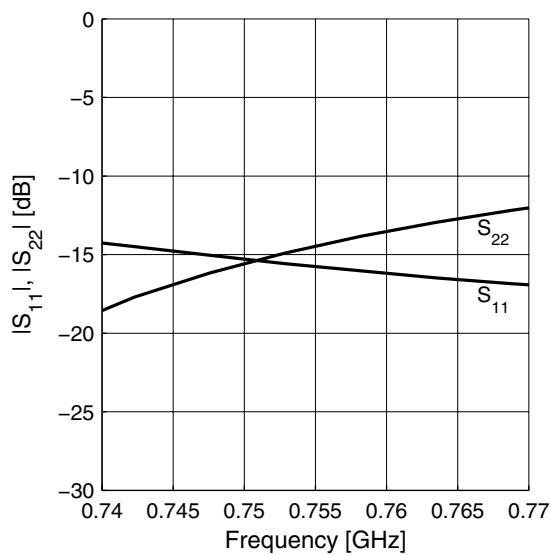
**Power Gain**  $|S_{21}| = f(f)$



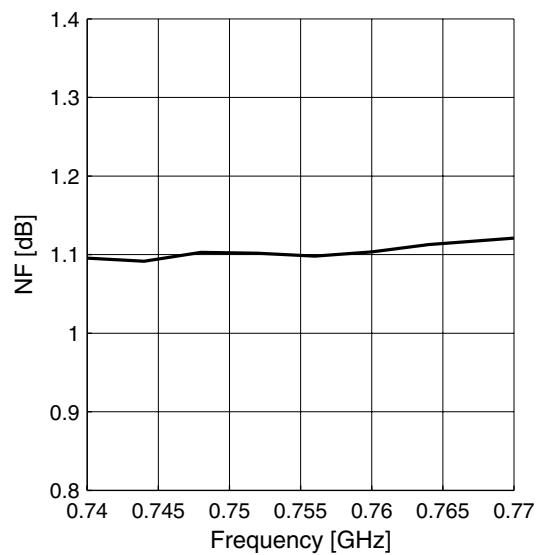
**Power Gain wideband**  $|S_{21}| = f(f)$



**Matching**  $|S_{11}| = f(f)$ ,  $|S_{22}| = f(f)$



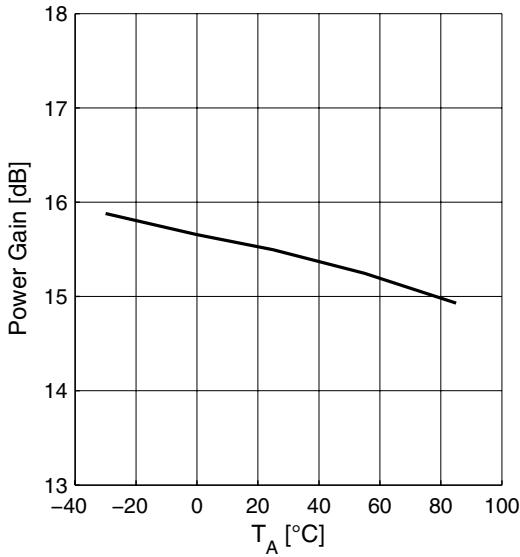
**Noise Figure**  $NF = f(f)$



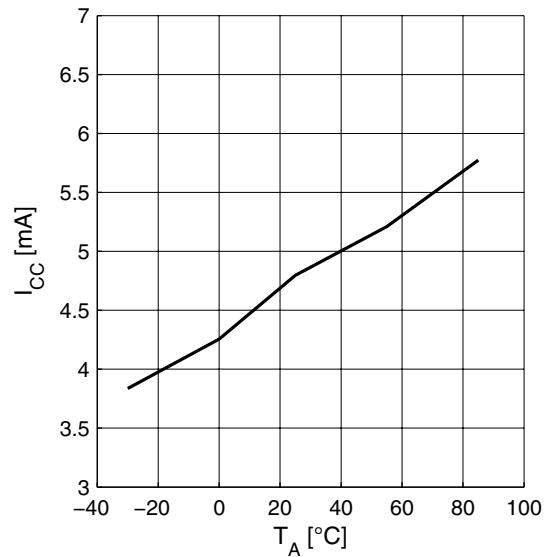
### 2.13 Measured Performance Band XIII High Gain Mode vs. Temperature

$V_{CC} = 2.8 \text{ V}$ ,  $V_{GS} = 2.8 \text{ V}$ ,  $V_{EN} = 2.8 \text{ V}$ ,  $f = 750 \text{ MHz}$ ,  $R_{REF} = 5.6 \text{ k}\Omega$

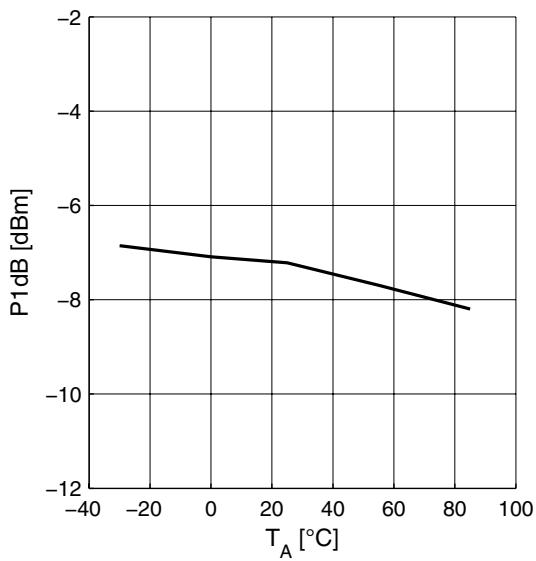
**Power Gain**  $|S_{21}| = f(T_A)$



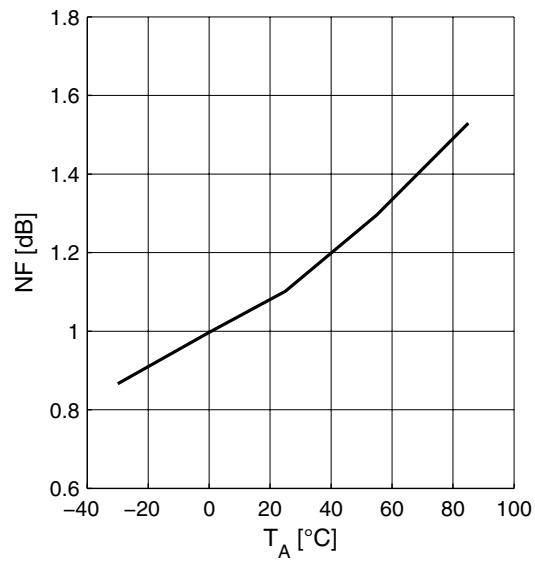
**Supply Current**  $I_{CC} = f(T_A)$



**Input Compression**  $P1dB = f(T_A)$



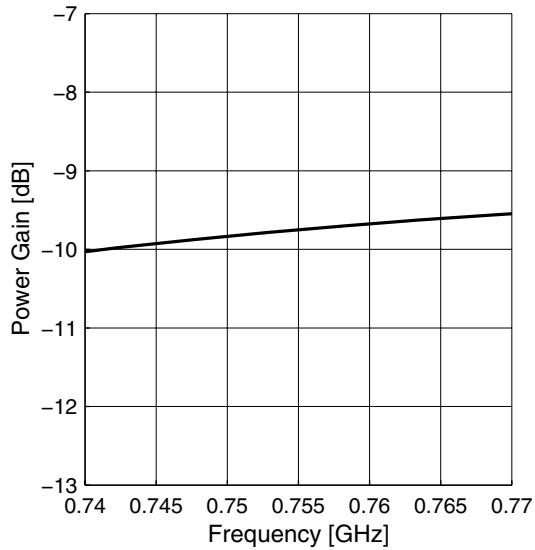
**Noise Figure**  $NF = f(T_A)$



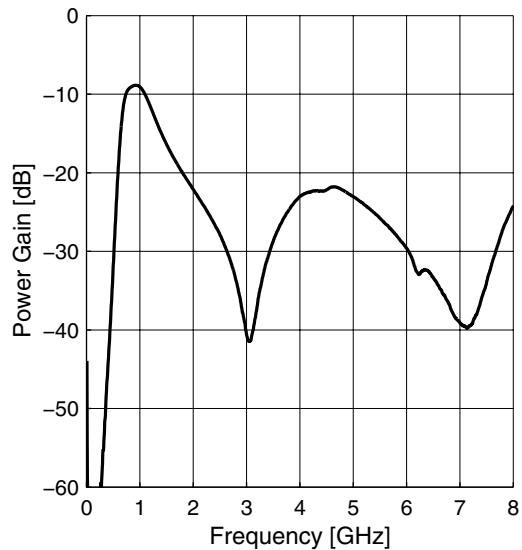
## 2.14 Measured Performance Band XIII Low Gain Mode vs. Frequency

$T_A = 25^\circ\text{C}$ ,  $V_{CC} = 2.8 \text{ V}$ ,  $V_{GS} = 0 \text{ V}$ ,  $V_{EN} = 2.8 \text{ V}$ ,  $R_{REF} = 5.6 \text{ k}\Omega$

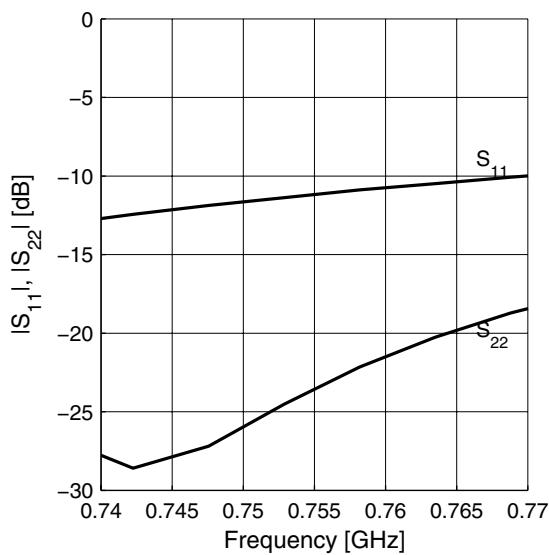
**Power Gain**  $|S_{21}| = f(f)$



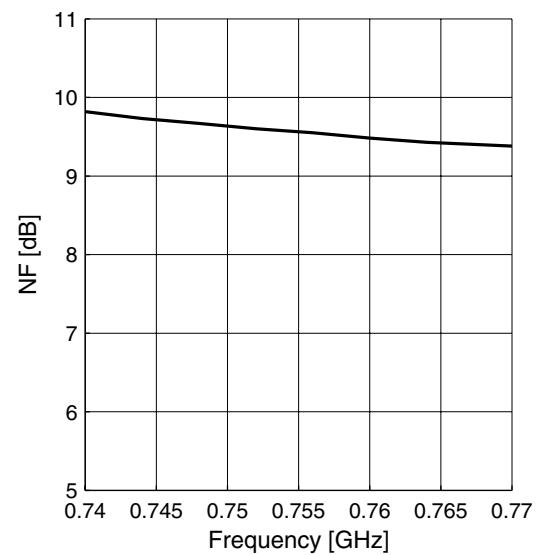
**Power Gain wideband**  $|S_{21}| = f(f)$



**Matching**  $|S_{11}| = f(f)$ ,  $|S_{22}| = f(f)$



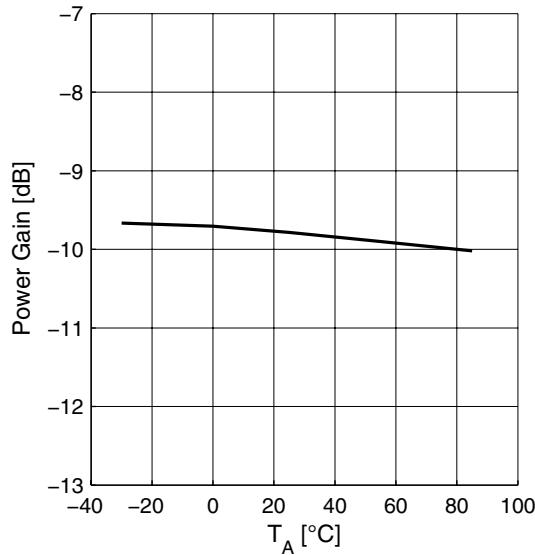
**Noise Figure**  $NF = f(f)$



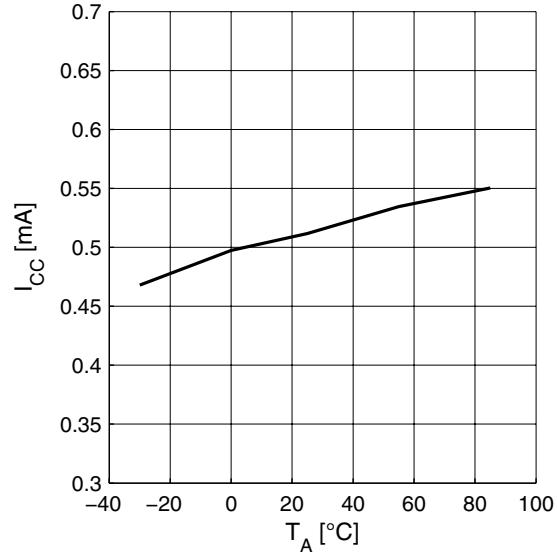
## 2.15 Measured Performance Band XIII Low Gain Mode vs. Temperature

$V_{CC} = 2.8 \text{ V}$ ,  $V_{GS} = 0 \text{ V}$ ,  $V_{EN} = 2.8 \text{ V}$ ,  $f = 750 \text{ MHz}$ ,  $R_{REF} = 5.6 \text{ k}\Omega$

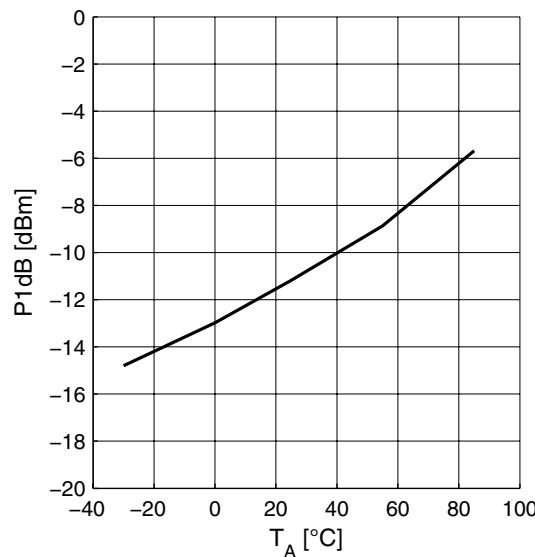
**Power Gain**  $|S_{21}| = f(T_A)$



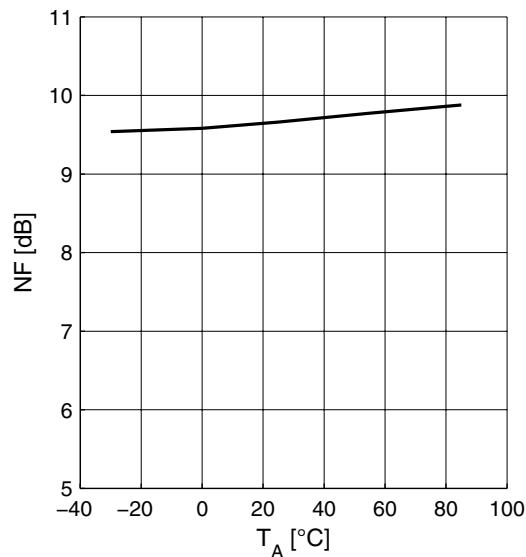
**Supply Current**  $I_{CC} = f(T_A)$



**Input Compression**  $P1dB = f(T_A)$

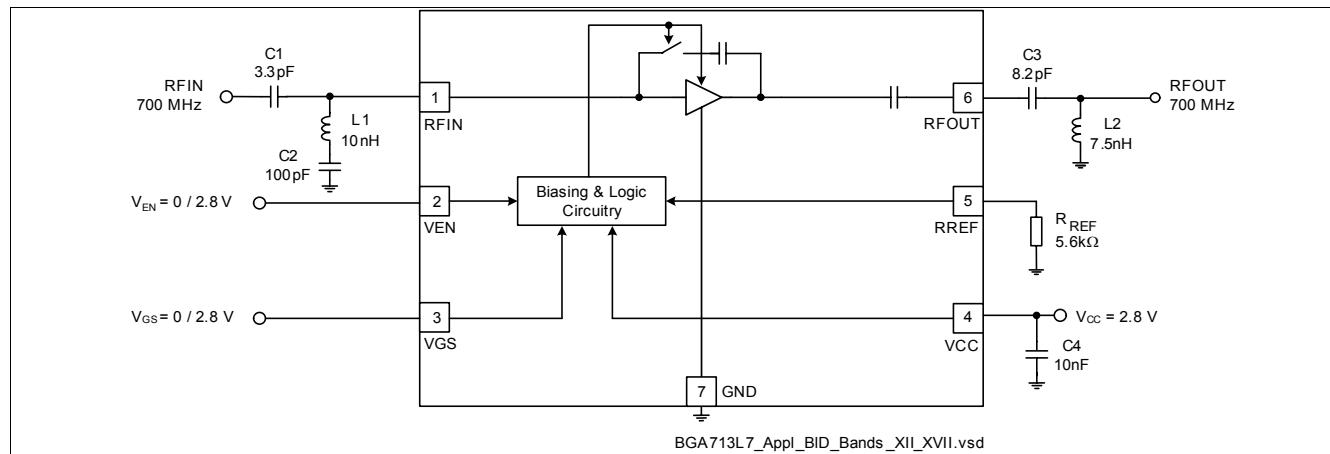


**Noise Figure**  $NF = f(T_A)$



### 3 Application Circuit and Block Diagram

#### 3.1 UMTS Bands XII and XVII Application Circuit Schematic



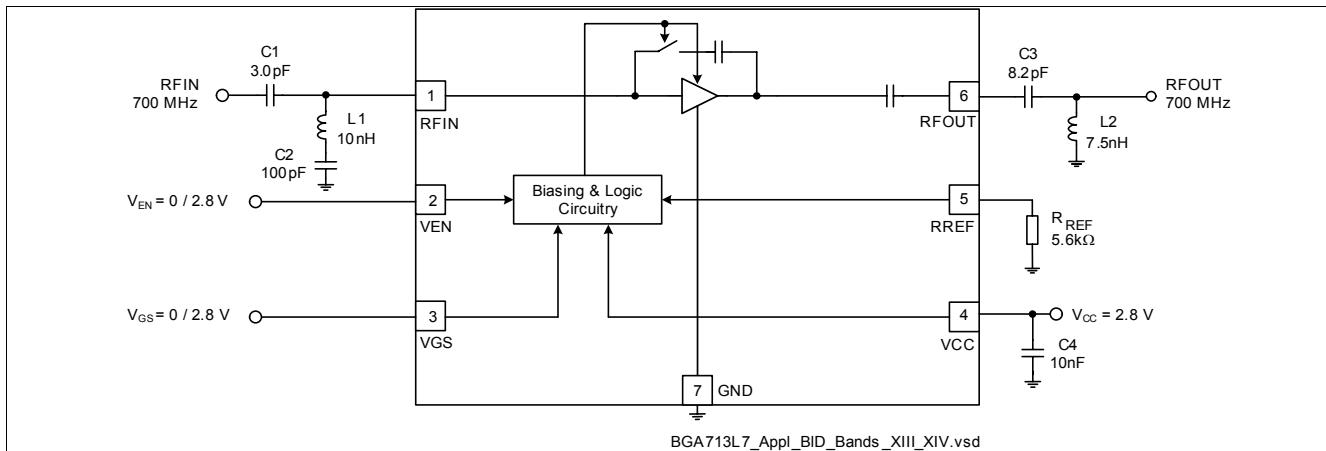
**Figure 2 Application Circuit with Chip Outline (top view)**

Note: Package paddle (Pin 7) has to be RF grounded.

**Table 10 Parts List**

Part Number	Part Type	Manufacturer	Size	Comment
L1 ... L2	Chip inductor	Various	0402	Wirewound, Q ≈ 50
C1 ... C4	Chip capacitor	Various	0402	
RREF	Chip resistor	Various	0402	

### 3.2 UMTS Bands XIII and XIV Application Circuit Schematic



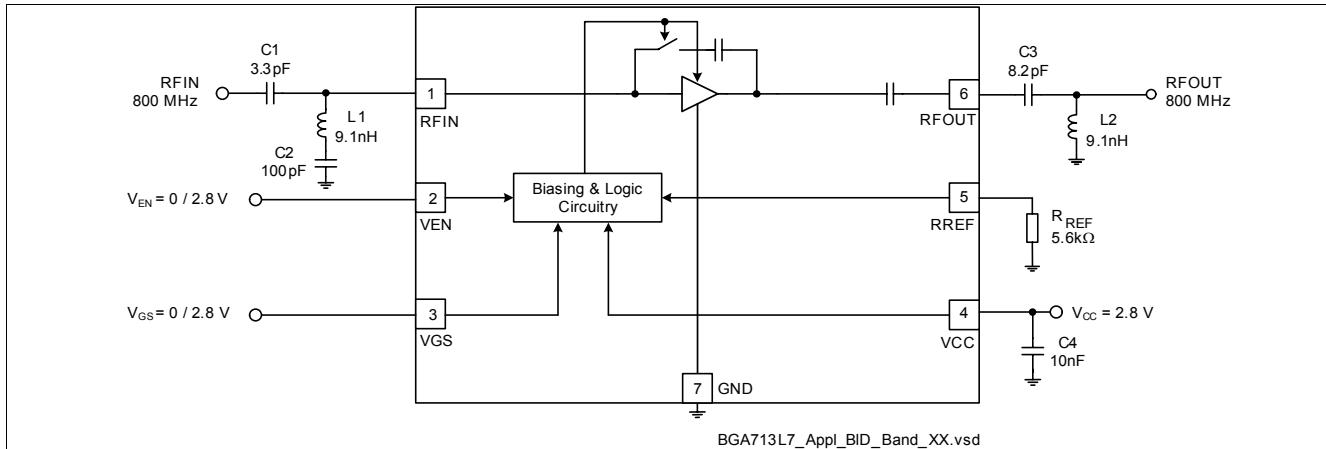
**Figure 3 Application Circuit with Chip Outline (top view)**

Note: Package paddle (Pin 7) has to be RF grounded.

**Table 11 Parts List**

Part Number	Part Type	Manufacturer	Size	Comment
L1 ... L2	Chip inductor	Various	0402	Wirewound, Q ≈ 50
C1 ... C4	Chip capacitor	Various	0402	
RREF	Chip resistor	Various	0402	

### 3.3 UMTS Bands XX Application Circuit Schematic



**Figure 4 Application Circuit with Chip Outline (top view)**

Note: Package paddle (Pin 7) has to be RF grounded.

**Table 12 Parts List**

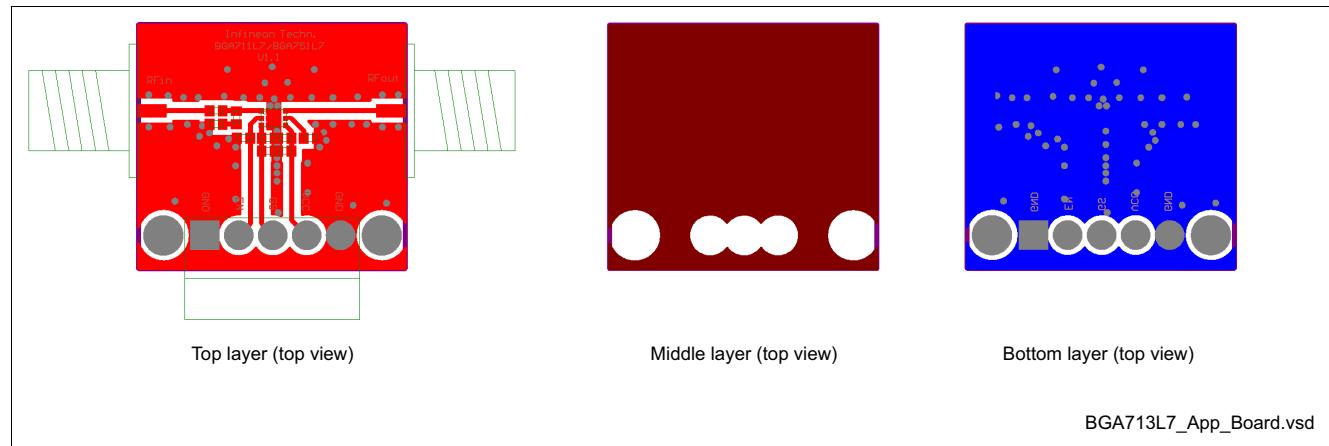
Part Number	Part Type	Manufacturer	Size	Comment
L1 ... L2	Chip inductor	Various	0402	Wirewound, Q ≈ 50
C1 ... C4	Chip capacitor	Various	0402	
RREF	Chip resistor	Various	0402	

### 3.4 Pin Description

Table 13 Pin Definition and Function

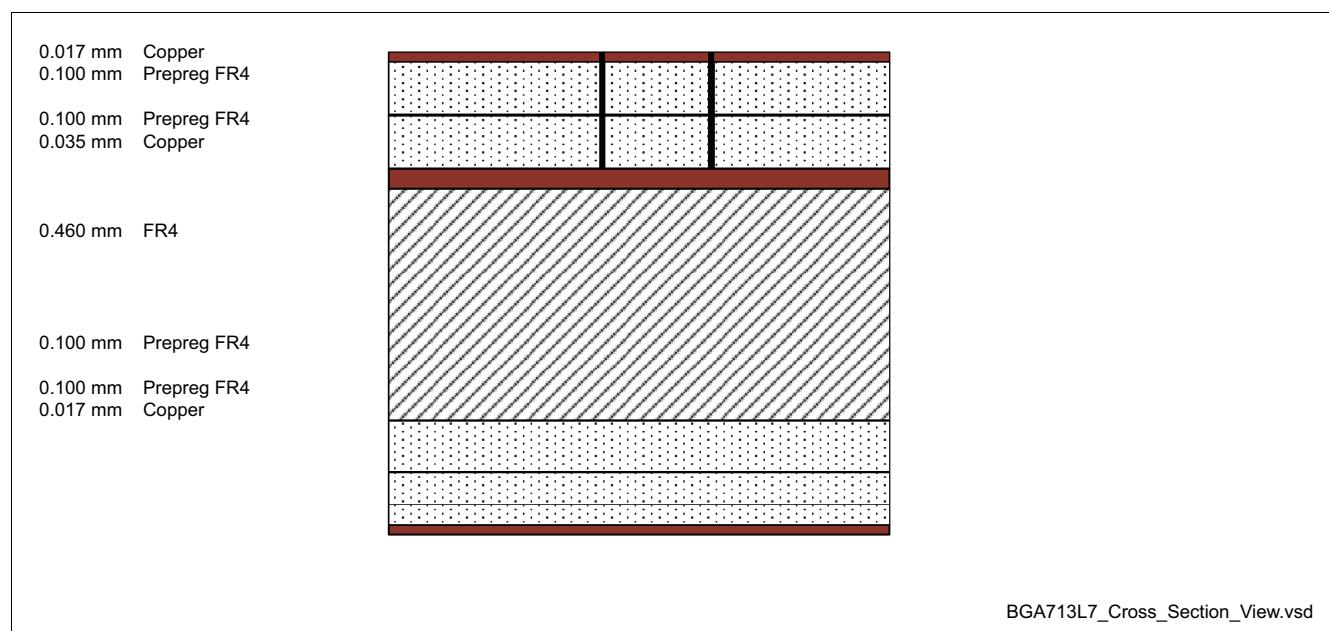
Pin No.	Name	Pin Type	Buffer Type	Function
1	RFIN			LNA input
2	VEN			Band select control
3	VGS			Gain step control
4	VCC			Supply voltage
5	RREF			Bias current reference resistor (high gain mode)
6	RFOUT			LNA output
7	GND			Ground Package paddle; ground connection and control circuitry

### 3.5 Application Board

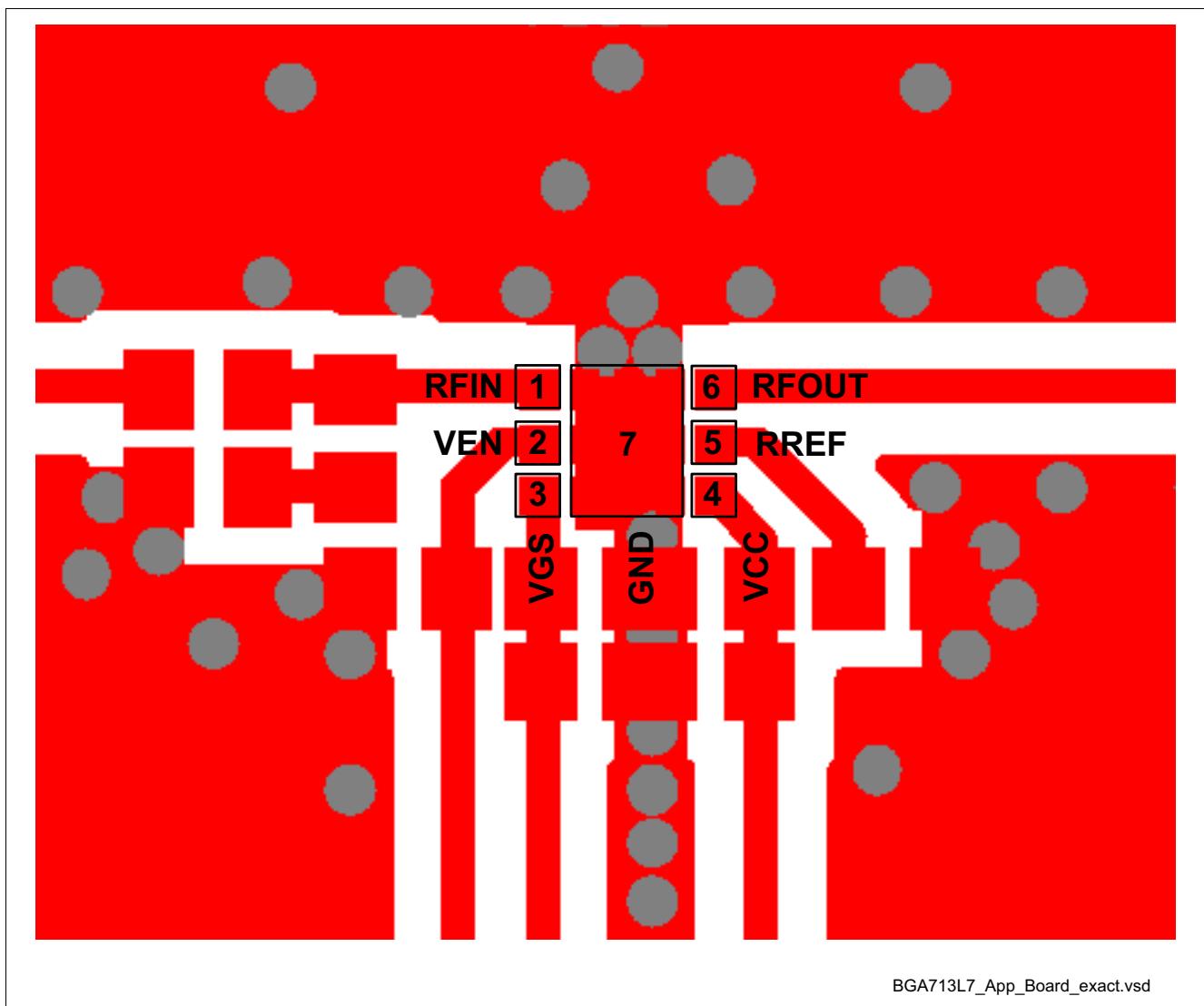


**Figure 5 Application Board Layout on 3-layer FR4**

Note: Top layer thickness: 0.2 mm, bottom layer thickness: 0.8 mm, 17 mm Cu metallization, gold plated. Board size: 21 x 18 mm.



**Figure 6 Cross-Section view of Application Board**

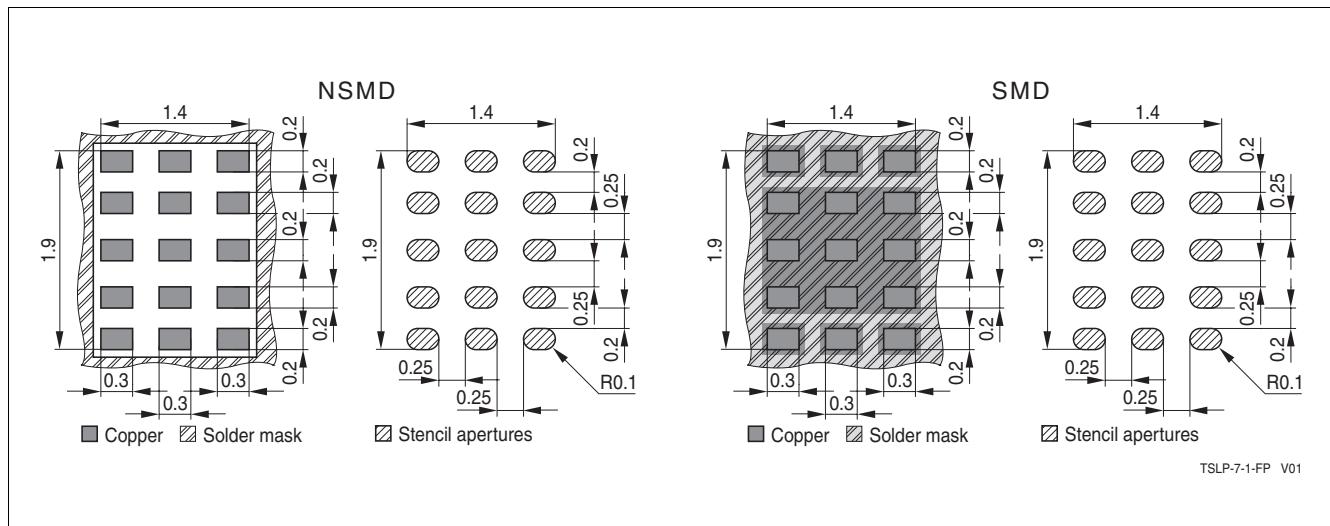


**Figure 7 Detail of Application Board Layout**

*Note: In order to achieve the same performance as given in this datasheet please follow the suggested PCB-layout as closely as possible. The position of the GND vias is critical for RF performance.*

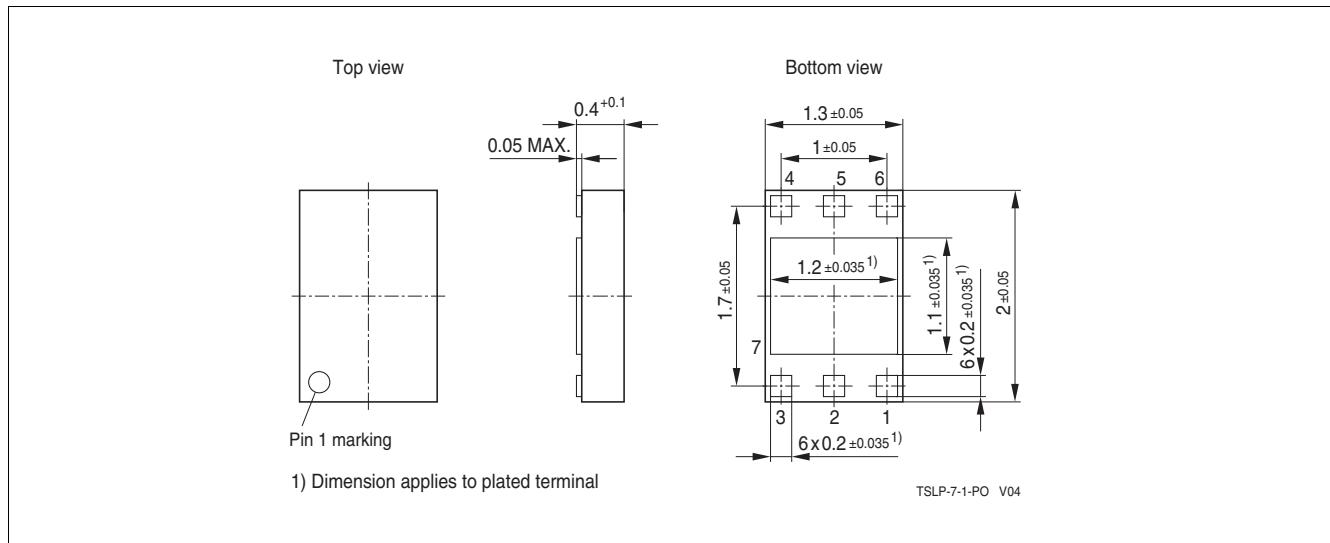
## 4 Physical Characteristics

### 4.1 Package Footprint



**Figure 8 Recommended Footprint and Stencil Layout for the TSLP-7-1 Package**

### 4.2 Package Dimensions



**Figure 9 Package Outline (top, side and bottom view)**

#### 4.3 Product Marking Pattern

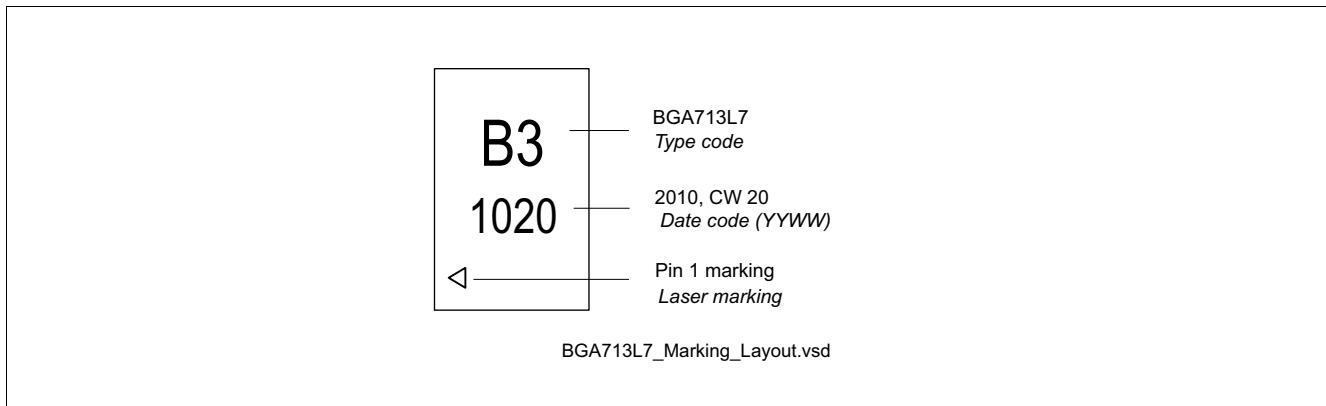


Figure 10 Marking Pattern (top view)

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